SVENSK STANDARD SS-EN IEC 61326-1



Utgåva 4

2021-09-22

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REDLINE VERSION

Elektrisk utrustning för mätning, styrning och för laboratorieändamål – EMC-fordringar –

Del 1: Allmänna fordringar

Electrical equipment for measurement, control and laboratory use – EMC requirements –

Part 1: General requirements

En så kallad "Redline version" (RLV) innehåller både den fastställda IEC-standarden och en ändringsmarkerad standard. Alla tillägg och borttagningar sedan den tidigare utgåvan är markerade med färg. Med en RLV sparar du mycket tid när du ska identifiera och bedöma aktuella ändringar i standarden. SEK Svensk Elstandard kan bara ge ut en RLV i de fall den finns tillgänglig från IEC.





Edition 3.0 2020-10 REDLINE VERSION

INTERNATIONAL **STANDARD**



Electrical equipment for measurement, control and laboratory use -**EMC** requirements -

Part 1: General requirements

INTERNATIONAL **ELECTROTECHNICAL COMMISSION**

ICS 17.220.20; 25.040.40; 33.100.20

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CONTENTS

		PRD	
IN	ITRODU	JCTION	2
1	Scop	pe	7
2	Norn	native references	8
3	Term	ns, definitions and abbreviations	9
	3.1	Terms and definitions	9
	3.2	Abbreviations	12
4	Gen	eral	12
5	EMC	test plan	13
	5.1	General	13
	5.2	Configuration of EUT during testing	13
	5.2.1		
	5.2.2	Composition of EUT	13
	5.2.3	•	
	5.2.4		
	5.2.5		
	5.2.6	3 (3 3)	
	5.3	Operation conditions of EUT during testing	
	5.3.1 5.3.2	·	
	5.3.2		
	5.4	Specification of FUNCTIONAL PERFORMANCE	
	5.5	Test description	
6		unity requirements	
	6.1	Conditions during the tests	
	6.2	Immunity test requirements	
	6.3	Random aspects	
	6.4	Performance criteria	
	6.4.1	General	22
	6.4.2	Performance criterion A	22
	6.4.3	Performance criterion B	22
	6.4.4	Performance criterion C	22
7	Emis	sion requirements	23
	7.1	Conditions during measurements	
	7.2	Emission limits	
8		results and test report	
9	Instr	uctions for use	24
		(normative) Immunity test requirements for PORTABLE TEST AND MEASUREMENT T powered by battery or from the circuit being measured	25
		(informative) Guide for analysis and assessment for electromagnetic	_
CC		lity	
	B.1	General	
	B.2	Risk analysis	
Ь.	B.3	Risk assessment	
Ы	DIIOGrai	bhy	∠9

Figure 1 – Examples of ports	11
Table 1 – Immunity test requirements for equipment intended to be used in a BASIC ELECTROMAGNETIC ENVIRONMENT	16
Table 2 – Immunity test requirements for equipment intended to be used in an INDUSTRIAL ELECTROMAGNETIC ENVIRONMENT	18
Table 3 – Immunity test requirements for equipment intended to be used in a CONTROLLED ELECTROMAGNETIC ENVIRONMENT	20
Table A.1 – Immunity test requirements for PORTABLE TEST AND MEASUREMENT EQUIPMENT	25

INTERNATIONAL ELECTROTECHNICAL COMMISSION

ELECTRICAL EQUIPMENT FOR MEASUREMENT, CONTROL AND LABORATORY USE – EMC REQUIREMENTS –

Part 1: General requirements

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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This redline version of the official IEC Standard allows the user to identify the changes made to the previous edition. A vertical bar appears in the margin wherever a change has been made. Additions are in green text, deletions are in strikethrough red text.

International Standard IEC 61326-1 has been prepared by subcommittee 65A: System aspects, of IEC technical committee 65: Industrial-process measurement, control and automation.

This third edition cancels and replaces the second edition, published in 2012. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- the immunity test levels and performance criteria have been reviewed;
- requirements for portable test and measurement equipment have been clarified and amended;
- the description of the electromagnetic environments has been improved.

The text of this International Standard is based on the following documents:

FDIS	Report on voting
65A/975/FDIS	65A/985/RVD

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

In this document, the following print types are used:

 Terms used throughout this document which have been defined in Clause 3: SMALL CAPITALS

A list of all parts of the IEC 61326 series under the general title *Electrical equipment for measurement, control and laboratory use - EMC requirements*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

INTRODUCTION

Instruments and equipment within the scope of this document may often be geographically widespread and hence operate under a wide range of environmental conditions.

The limitation of undesired electromagnetic emissions ensures that no other equipment installed nearby is unduly influenced by the equipment under consideration. The limits are more or less specified by, and therefore taken from, IEC and International Special Committee on Radio Interference (CISPR) publications.

However, the equipment should function without undue degradation in an electromagnetic environment typical for the locations where it is intended to be operated. In this respect, the document specifies three different types of electromagnetic environment and the levels for immunity. More detailed information about issues related to electromagnetic environments are given in IEC TR 61000-2-5. Special risks, involving for example nearby or direct lightning strikes, circuit-breaking, or exceptionally high electromagnetic radiation in close proximity, are not covered.

Complex electric and/or electronic systems should require EMC planning in all phases of their design and installation, taking into consideration the electromagnetic environment, any special requirements, and the severity of failures.

This part of IEC 61326 specifies the EMC requirements that are generally applicable to all equipment within its scope. For certain types of equipment, these requirements will be supplemented or modified by the special requirements of one, or more than one, particular part IEC 61326-2 (all parts). These should be read in conjunction with the IEC 61326-1 requirements.

ELECTRICAL EQUIPMENT FOR MEASUREMENT, CONTROL AND LABORATORY USE – EMC REQUIREMENTS –

Part 1: General requirements

1 Scope

This part of IEC 61326 specifies requirements for immunity and emissions regarding electromagnetic compatibility (EMC) for electrical equipment, operating from a supply or battery of less than 1 000 V AC or 1 500 V DC or from the circuit being measured. Equipment intended for professional, industrial-process, industrial-manufacturing and educational use is covered by this part. It includes equipment and computing devices for

- measurement and test;
- control;
- LABORATORY use:
- accessories intended for use with the above (such as sample handling equipment),

intended to be used in industrial and non-industrial locations.

Computing devices and assemblies and similar equipment within the scope of information technology equipment (ITE) and complying with applicable ITE EMC standards—may can be used in systems within the scope of this part of IEC 61326 without additional testing, if they are suitable for the intended electromagnetic environment.

It is generally considered that this product family standard takes precedence over the corresponding generic EMC standards.

The following equipment is covered by this document.

a) Electrical measurement and test equipment

This is equipment which, by electrical means, measures, indicates or records one or more electrical or non-electrical quantities, also non-measuring equipment such as signal generators, measurement standards, power supplies and transducers.

b) Electrical control equipment

This is equipment which controls one or more output quantities to specific values, with each value determined by manual settings, by local or remote programming, or by one or more input variables. This includes industrial process measurement and control (IPMC) equipment, which consists of devices such as:

- process controllers and regulators;
- programmable controllers;
- power supply units for equipment and systems (centralized or dedicated);
- analogue/digital indicators and recorders;
- process instrumentation;
- transducers, positioners, intelligent actuators, etc.

c) Electrical laboratory equipment

This is equipment which measures, indicates monitors or analyses substances, or is used to prepare materials, and includes In Vitro Diagnostic (IVD) equipment. This equipment

may also be used in areas other than laboratories, for example self-test IVD equipment may be used in the home.

- c) Electrical LABORATORY equipment, including In Vitro Diagnostic (IVD) medical equipment
 This is equipment used to prepare or analyse materials, or measure, indicate or monitor
 physical quantities. This equipment might also be used in areas other than laboratories.
- d) Equipment a), b) or c) as above when being equipped with components having radio functionality, for example for wireless communication.

Equipment within the scope of this document might be operated in different electromagnetic environments; depending on the electromagnetic environment different emission and immunity test requirements are applicable.

This document considers three types of electromagnetic environments:

- BASIC ELECTROMAGNETIC ENVIRONMENT;
- INDUSTRIAL ELECTROMAGNETIC ENVIRONMENT;
- CONTROLLED ELECTROMAGNETIC ENVIRONMENT.

Corresponding immunity test requirements are described in Clause 6.

In terms of emission requirements, equipment shall be classified in Class A or Class B equipment, as per the requirements and procedure of CISPR 11. The corresponding emission requirements are described in Clause 7.

The specified emission and immunity requirements aim at achieving electromagnetic compatibility between equipment covered in this document and other equipment that might operate at locations with electromagnetic environments considered in this document. Guidance for an assessment concerning the risk for achieving EMC is given in Annex B.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

```
IEC 60050-161:1990, International Electrotechnical Vocabulary (IEV) – Part 161: Electromagnetic compatibility
IEC 60050-161:1990/AMD1:1997
IEC 60050-161:1990/AMD2:1998
IEC 60050-161:1990/AMD3:2014
IEC 60050-161:1990/AMD5:2015
IEC 60050-161:1990/AMD6:2016
IEC 60050-161:1990/AMD7:2017
IEC 60050-161:1990/AMD8:2018
(available at <a href="http://www.electropedia.org">http://www.electropedia.org</a>)
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IEC 61000-3-2:\frac{2005}{2018}, Electromagnetic compatibility (EMC) — Part 3-2: Limits — Limits for harmonic current emissions (equipment input current \leq 16 A per phase) Amendment 1:\frac{2008}{2009}
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IEC 61000-3-3:20082013, Electromagnetic compatibility (EMC) – Part 3-3: Limits – Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current ≤16 A per phase and not subject to conditional connection IEC 61000-3-3:2013/AMD1:2017

IEC 61000-3-11:20002017, Electromagnetic compatibility (EMC) – Part 3-11: Limits – Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems –Equipment with rated current ≤75 A and subject to conditional connection

IEC 61000-3-12:2011, Electromagnetic compatibility (EMC) — Part 3-12: Limits — Limits for harmonic currents produced by equipment connected to public low-voltage systems with input current >16 A and ≤75 A per phase

IEC 61000-4-2:2008, Electromagnetic compatibility (EMC) – Part 4-2: Testing and measurement techniques – Electrostatic discharge immunity test

IEC 61000-4-3:2006, Electromagnetic compatibility (EMC) – Part 4-3: Testing and measurement techniques – Radiated, radio-frequency, electromagnetic field immunity test IEC 61000-4-3:2006/AMD1:2007 IEC 61000-4-3:2006/AMD2:2010

IEC 61000-4-4:20042012, Electromagnetic compatibility (EMC) – Part 4-4: Testing and measurement techniques – Electrical fast transient/burst immunity test

Amendment 1:2010

IEC 61000-4-5:20052014, Electromagnetic compatibility (EMC) – Part 4-5: Testing and measurement techniques – Surge immunity test IEC 61000-4-5:2014/AMD1:2017

IEC 61000-4-6:20082013, Electromagnetic compatibility (EMC) – Part 4-6: Testing and measurement techniques – Immunity to conducted disturbances, induced by radio-frequency fields

IEC 61000-4-8:2009, Electromagnetic compatibility (EMC) – Part 4-8: Testing and measurement techniques – Power frequency magnetic field immunity test

IEC 61000-4-11:20042020, Electromagnetic compatibility (EMC) – Part 4-11: Testing and measurement techniques – Voltage dips, short interruptions and voltage variations immunity tests for equipment with input current up to 16 A per phase

CISPR 11:20092015, Industrial, scientific and medical equipment – Radio-frequency disturbance characteristics – Limits and methods of measurement Amendment 1:2010

CISPR 11:2015/AMD1:2016 CISPR 11:2015/AMD2:2019





Fastställd 2021-09-22 Utgåva 4 Sida

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Ansvarig kommitté

SEK TK 65

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Elektrisk utrustning för mätning, styrning och för laboratorieändamål – EMC-fordringar – Del 1: Allmänna fordringar

Electrical equipment for measurement, control and laboratory use – EMC requirements –

Part 1: General requirements

Som svensk standard gäller europastandarden EN IEC 61326-1:2021. Den svenska standarden innehåller den officiella engelska språkversionen av EN IEC 61326-1:2021.

Nationellt förord

Europastandarden EN IEC 61326-1:2021

består av:

- europastandardens ikraftsättningsdokument, utarbetat inom CENELEC
- IEC 61326-1, Third edition, 2020 Electrical equipment for measurement, control and laboratory use EMC requirements Part 1: General requirements

utarbetad inom International Electrotechnical Commission, IEC.

Tidigare fastställd svensk standard SS-EN 61326-1, utgåva 3, 2013, gäller ej fr o m 2024-06-04.

ICS 33.100.20; 25.040.40; 17.220.20

Standarder underlättar utvecklingen och höjer elsäkerheten

Det finns många fördelar med att ha gemensamma tekniska regler för bl a mätning, säkerhet och provning och för utförande, skötsel och dokumentation av elprodukter och elanläggningar.

Genom att utforma sådana standarder blir säkerhetsfordringar tydliga och utvecklingskostnaderna rimliga samtidigt som marknadens acceptans för produkten eller tjänsten ökar.

Många standarder inom elområdet beskriver tekniska lösningar och metoder som åstadkommer den elsäkerhet som föreskrivs av svenska myndigheter och av EU.

SEK är Sveriges röst i standardiseringsarbetet inom elområdet

SEK Svensk Elstandard svarar för standardiseringen inom elområdet i Sverige och samordnar svensk medverkan i internationell och europeisk standardisering. SEK är en ideell organisation med frivilligt deltagande från svenska myndigheter, företag och organisationer som vill medverka till och påverka utformningen av tekniska regler inom elektrotekniken.

SEK samordnar svenska intressenters medverkan i SEKs tekniska kommittéer och stödjer svenska experters medverkan i internationella och europeiska projekt.

Stora delar av arbetet sker internationellt

Utformningen av standarder sker i allt väsentligt i internationellt och europeiskt samarbete. SEK är svensk nationalkommitté av International Electrotechnical Commission (IEC) och Comité Européen de Normalisation Electrotechnique (CENELEC).

Standardiseringsarbetet inom SEK är organiserat i referensgrupper bestående av ett antal tekniska kommittéer som speglar hur arbetet inom IEC och CENELEC är organiserat.

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Var med och påverka!

Den som deltar i SEKs tekniska kommittéarbete har möjlighet att påverka framtida standarder och får tidig tillgång till information och dokumentation om utvecklingen inom sitt teknikområde. Arbetet och kontakterna med kollegor, kunder och konkurrenter kan gynnsamt påverka enskilda företags affärsutveckling och bidrar till deltagarnas egen kompetensutveckling.

Du som vill dra nytta av dessa möjligheter är välkommen att kontakta SEKs kansli för mer information.

SEK Svensk Elstandard

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EUROPEAN STANDARD NORME EUROPÉENNE EUROPÄISCHE NORM

EN IEC 61326-1

June 2021

ICS 25.040.40; 17.220.20; 33.100.20

Supersedes EN 61326-1:2013 and all of its amendments and corrigenda (if any)

English Version

Electrical equipment for measurement, control and laboratory use - EMC requirements - Part 1: General requirements (IEC 61326-1:2020)

Matériel électrique de mesure, de commande et de laboratoire - Exigences relatives à la CEM - Partie 1:

Exigences générales
(IEC 61326-1:2020)

Elektrische Mess-, Steuer-, Regel- und Laborgeräte - EMV-Anforderungen - Teil 1: Allgemeine Anforderungen (IEC 61326-1:2020)

This European Standard was approved by CENELEC on 2020-11-30. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the CEN-CENELEC Management Centre or to any CENELEC member.

This European Standard exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the CEN-CENELEC Management Centre has the same status as the official versions.

CENELEC members are the national electrotechnical committees of Austria, Belgium, Bulgaria, Croatia, Cyprus, the Czech Republic, Denmark, Estonia, Finland, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Latvia, Lithuania, Luxembourg, Malta, the Netherlands, Norway, Poland, Portugal, Republic of North Macedonia, Romania, Serbia, Slovakia, Slovenia, Spain, Sweden, Switzerland, Turkey and the United Kingdom.



European Committee for Electrotechnical Standardization Comité Européen de Normalisation Electrotechnique Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Rue de la Science 23, B-1040 Brussels

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Ref. No. EN IEC 61326-1:2021 E

European foreword

The text of document 65A/975/FDIS, future edition 3 of IEC 61326-1, prepared by SC 65A "System aspects" of IEC/TC 65 "Industrial-process measurement, control and automation" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN IEC 61326-1:2021.

The following dates are fixed:

•	latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement	(dop)	2021-12-04
•	latest date by which the national standards conflicting with	(dow)	2024-06-04

This document supersedes EN 61326-1:2013 and all of its amendments and corrigenda (if any).

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. CENELEC shall not be held responsible for identifying any or all such patent rights.

This document has been prepared under a mandate given to CENELEC by the European Commission and the European Free Trade Association.

Endorsement notice

The text of the International Standard IEC 61326-1:2020 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 60359	NOTE	Harmonized as EN 60359
IEC 61000-6-1:2016	NOTE	Harmonized as EN IEC 61000-6-1:2019 (not modified)
IEC 61000-6-2:2016	NOTE	Harmonized as EN IEC 61000-6-2:2019 (not modified)
IEC 61010 (series)	NOTE	Harmonized as EN IEC 61010 (series)
IEC 61326-2 (series)	NOTE	Harmonized as EN 61326-2 (series)

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 Where an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	EN/HD	<u>Year</u>
IEC 60050-161	1990	International Electrotechnical Vocabulary. Chapter 161: Electromagnetic compatibility	-	-
+ A1	1997		-	-
+ A2	1998		-	-
+ A3	2014		-	-
+ A4	2014		-	-
+ A5	2015		-	-
+ A6	2016		-	-
+ A7	2017		-	-
+ A8	2018		-	-
IEC 61000-3-2	2018	Electromagnetic compatibility (EMC) – Part 3-2: Limits – Limits for harmonic current emissions (equipment input current ≤16 A per phase)	EN IEC 61000-3-2	2019
IEC 61000-3-3	2013	Electromagnetic compatibility (EMC) - Part 3-3: Limits - Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current ≤16 A per phase and not subject to conditional connection	EN 61000-3-3	2013
+ A1	2017		+ A1	2019
IEC 61000-3-11	2017	Electromagnetic compatibility (EMC) – Part 3-11: Limits – Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems – Equipment with rated current ≤75 A and subject to conditional connection	EN IEC 61000-3-11	2019

EN IEC 61326-1:2021 (E)

<u>Publication</u>	<u>Year</u>	<u>Title</u>	EN/HD	<u>Year</u>
IEC 61000-3-12	2011	Electromagnetic compatibility (EMC) - Part 3-12: Limits - Limits for harmonic currents produced by equipment connected to public low-voltage systems with input current >16 A and ≤75 A per phase	EN 61000-3-12	2011
IEC 61000-4-2	2008	Electromagnetic compatibility (EMC) - Part 4-2: Testing and measurement techniques - Electrostatic discharge immunity test	EN 61000-4-2	2009
IEC 61000-4-3	2006	Electromagnetic compatibility (EMC) - Part 4-3: Testing and measurement techniques - Radiated, radio-frequency, electromagnetic field immunity test	EN 61000-4-3	2006
+ A1	2007		+ A1	2008
+ A2	2010		+ A2	2010
IEC 61000-4-4	2012	Electromagnetic compatibility (EMC) - Part 4-4: Testing and measurement techniques - Electrical fast transient/burst immunity test	EN 61000-4-4	2012
IEC 61000-4-5	2014	Electromagnetic compatibility (EMC) - Part 4-5: Testing and measurement techniques - Surge immunity test	EN 61000-4-5	2014
+ A1	2017		+ A1	2017
+ A1 IEC 61000-4-6	2017 2013	Electromagnetic compatibility (EMC) - Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields	+ A1 EN 61000-4-6	2017 2014
		4-6: Testing and measurement techniquesImmunity to conducted disturbances,		
IEC 61000-4-6	2013	4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields Electromagnetic compatibility (EMC) - Part 4-8: Testing and measurement techniques - Power frequency magnetic field immunity	EN 61000-4-6	2014
IEC 61000-4-6	2013	4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields Electromagnetic compatibility (EMC) - Part 4-8: Testing and measurement techniques - Power frequency magnetic field immunity test Electromagnetic compatibility (EMC) - Part 4-11: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests for equipment with input	EN 61000-4-6 EN 61000-4-8	2014
IEC 61000-4-6 IEC 61000-4-8 IEC 61000-4-11	2013 2009 2020	4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields Electromagnetic compatibility (EMC) - Part 4-8: Testing and measurement techniques - Power frequency magnetic field immunity test Electromagnetic compatibility (EMC) - Part 4-11: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests for equipment with input current up to 16 A per phase Industrial, scientific and medical equipment - Radio-frequency disturbance characteristics - Limits and methods of	EN 61000-4-6 EN 61000-4-8 EN IEC 61000-4-11	2014 2010 2020
IEC 61000-4-6 IEC 61000-4-8 IEC 61000-4-11 CISPR 11 (mod)	2013 2009 2020 2015	4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields Electromagnetic compatibility (EMC) - Part 4-8: Testing and measurement techniques - Power frequency magnetic field immunity test Electromagnetic compatibility (EMC) - Part 4-11: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests for equipment with input current up to 16 A per phase Industrial, scientific and medical equipment - Radio-frequency disturbance characteristics - Limits and methods of	EN 61000-4-6 EN 61000-4-8 EN IEC 61000-4-11	2014 2010 2020 2016



Edition 3.0 2020-10

INTERNATIONAL STANDARD

NORME INTERNATIONALE

Electrical equipment for measurement, control and laboratory use -**EMC** requirements -

Part 1: General requirements

Matériel électrique de mesure, de commande et de laboratoire -Exigences relatives à la CEM -Partie 1: Exigences générales

SEK Svensk Elstandard

CONTENTS

F	DREWO	RD	4
IN	TRODU	CTION	6
1		e	
2		ative references	
3		s, definitions and abbreviations	
J	3.1	Terms and definitions	
	3.1	Abbreviations	
4		ral	
5		test plan	
5		·	
	5.1	General	
	5.2 5.2.1	Configuration of EUT during testing	
	5.2.1	Composition of EUT	
	5.2.2	Assembly of EUT	
	5.2.3	I/O PORTS	
	5.2.5	AUXILIARY EQUIPMENT	
	5.2.6	Cabling and earthing (grounding)	
	5.3	Operation conditions of EUT during testing	
	5.3.1	Operation modes	
	5.3.2	Environmental conditions	
	5.3.3		
	5.4	Specification of FUNCTIONAL PERFORMANCE	
	5.5	Test description	
6	Immu	nity requirements	14
	6.1	Conditions during the tests	14
	6.2	Immunity test requirements	
	6.3	Random aspects	
	6.4	Performance criteria	18
	6.4.1	General	18
	6.4.2	Performance criterion A	18
	6.4.3	Performance criterion B	18
	6.4.4	Performance criterion C	18
7	Emis	sion requirements	19
	7.1	Conditions during measurements	19
	7.2	Emission limits	19
8	Test	results and test report	19
9	Instru	ctions for use	20
		normative) Immunity test requirements for PORTABLE TEST AND MEASUREMENT r powered by battery or from the circuit being measured	21
Ar	nex B (informative) Guide for analysis and assessment for electromagnetic	
		ity	22
	B.1	General	22
	B.2	Risk analysis	22
	B.3	Risk assessment	22
Ri	bliograp	hv	24

Figure 1 – Examples of ports	11
Table 1 – Immunity test requirements for equipment intended to be used in a BASIC ELECTROMAGNETIC ENVIRONMENT	15
Table 2 – Immunity test requirements for equipment intended to be used in an INDUSTRIAL ELECTROMAGNETIC ENVIRONMENT	16
Table 3 – Immunity test requirements for equipment intended to be used in a CONTROLLED ELECTROMAGNETIC ENVIRONMENT	17
Table A.1 – Immunity test requirements for PORTABLE TEST AND MEASUREMENT	21

INTERNATIONAL ELECTROTECHNICAL COMMISSION

ELECTRICAL EQUIPMENT FOR MEASUREMENT, CONTROL AND LABORATORY USE – EMC REQUIREMENTS –

Part 1: General requirements

FOREWORD

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International Standard IEC 61326-1 has been prepared by subcommittee 65A: System aspects, of IEC technical committee 65: Industrial-process measurement, control and automation.

This third edition cancels and replaces the second edition, published in 2012. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- the immunity test levels and performance criteria have been reviewed;
- requirements for portable test and measurement equipment have been clarified and amended;

- the description of the electromagnetic environments has been improved.

The text of this International Standard is based on the following documents:

FDIS	Report on voting
65A/975/FDIS	65A/985/RVD

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

In this document, the following print types are used:

 Terms used throughout this document which have been defined in Clause 3: SMALL CAPITALS

A list of all parts of the IEC 61326 series under the general title *Electrical equipment for measurement, control and laboratory use - EMC requirements*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific document. At this date, the document will be

- · reconfirmed,
- withdrawn,
- · replaced by a revised edition, or
- amended.

INTRODUCTION

Instruments and equipment within the scope of this document may often be geographically widespread and hence operate under a wide range of environmental conditions.

The limitation of undesired electromagnetic emissions ensures that no other equipment installed nearby is unduly influenced by the equipment under consideration. The limits are more or less specified by, and therefore taken from, IEC and International Special Committee on Radio Interference (CISPR) publications.

However, the equipment should function without undue degradation in an electromagnetic environment typical for the locations where it is intended to be operated. In this respect, the document specifies three different types of electromagnetic environment and the levels for immunity. More detailed information about issues related to electromagnetic environments are given in IEC TR 61000-2-5. Special risks, involving for example nearby or direct lightning strikes, circuit-breaking, or exceptionally high electromagnetic radiation in close proximity, are not covered.

Complex electric and/or electronic systems should require EMC planning in all phases of their design and installation, taking into consideration the electromagnetic environment, any special requirements, and the severity of failures.

This part of IEC 61326 specifies the EMC requirements that are generally applicable to all equipment within its scope. For certain types of equipment, these requirements will be supplemented or modified by the special requirements of one, or more than one, particular part IEC 61326-2 (all parts). These should be read in conjunction with the IEC 61326-1 requirements.

ELECTRICAL EQUIPMENT FOR MEASUREMENT, CONTROL AND LABORATORY USE – EMC REQUIREMENTS –

Part 1: General requirements

1 Scope

This part of IEC 61326 specifies requirements for immunity and emissions regarding electromagnetic compatibility (EMC) for electrical equipment, operating from a supply or battery of less than 1 000 V AC or 1 500 V DC or from the circuit being measured. Equipment intended for professional, industrial-process, industrial-manufacturing and educational use is covered by this part. It includes equipment and computing devices for

- measurement and test;
- control;
- LABORATORY use:
- accessories intended for use with the above (such as sample handling equipment),

intended to be used in industrial and non-industrial locations.

Computing devices and assemblies and similar equipment within the scope of information technology equipment (ITE) and complying with applicable ITE EMC standards can be used in systems within the scope of this part of IEC 61326 without additional testing, if they are suitable for the intended electromagnetic environment.

It is generally considered that this product family standard takes precedence over the corresponding generic EMC standards.

The following equipment is covered by this document.

a) Electrical measurement and test equipment

This is equipment which, by electrical means, measures, indicates or records one or more electrical or non-electrical quantities, also non-measuring equipment such as signal generators, measurement standards, power supplies and transducers.

b) Electrical control equipment

This is equipment which controls one or more output quantities to specific values, with each value determined by manual settings, by local or remote programming, or by one or more input variables. This includes industrial process measurement and control (IPMC) equipment, which consists of devices such as:

- process controllers and regulators;
- programmable controllers;
- power supply units for equipment and systems (centralized or dedicated);
- analogue/digital indicators and recorders;
- process instrumentation;
- transducers, positioners, intelligent actuators, etc.
- c) Electrical LABORATORY equipment, including In Vitro Diagnostic (IVD) medical equipment
 This is equipment used to prepare or analyse materials, or measure, indicate or monitor
 physical quantities. This equipment might also be used in areas other than laboratories.

d) Equipment a), b) or c) as above when being equipped with components having radio functionality, for example for wireless communication.

Equipment within the scope of this document might be operated in different electromagnetic environments; depending on the electromagnetic environment different emission and immunity test requirements are applicable.

This document considers three types of electromagnetic environments:

- BASIC ELECTROMAGNETIC ENVIRONMENT;
- INDUSTRIAL ELECTROMAGNETIC ENVIRONMENT;
- CONTROLLED ELECTROMAGNETIC ENVIRONMENT.

Corresponding immunity test requirements are described in Clause 6.

In terms of emission requirements, equipment shall be classified in Class A or Class B equipment, as per the requirements and procedure of CISPR 11. The corresponding emission requirements are described in Clause 7.

The specified emission and immunity requirements aim at achieving electromagnetic compatibility between equipment covered in this document and other equipment that might operate at locations with electromagnetic environments considered in this document. Guidance for an assessment concerning the risk for achieving EMC is given in Annex B.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

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IEC 60050-161:1990, International Electrotechnical Vocabulary (IEV) — Part 161: Electromagnetic compatibility
IEC 60050-161:1990/AMD1:1997
IEC 60050-161:1990/AMD2:1998
IEC 60050-161:1990/AMD3:2014
IEC 60050-161:1990/AMD5:2015
IEC 60050-161:1990/AMD6:2016
IEC 60050-161:1990/AMD7:2017
IEC 60050-161:1990/AMD8:2018
(available at <a href="https://www.electropedia.org">https://www.electropedia.org</a>)
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IEC 61000-3-2:2018, Electromagnetic compatibility (EMC) — Part 3-2: Limits — Limits for harmonic current emissions (equipment input current ≤16 A per phase)

IEC 61000-3-3:2013, Electromagnetic compatibility (EMC) — Part 3-3: Limits — Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current ≤16 A per phase and not subject to conditional connection IEC 61000-3-3:2013/AMD1:2017

IEC 61000-3-11:2017, Electromagnetic compatibility (EMC) – Part 3-11: Limits – Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems – Equipment with rated current ≤75 A and subject to conditional connection

IEC 61000-3-12:2011, Electromagnetic compatibility (EMC) - Part 3-12: Limits - Limits for harmonic currents produced by equipment connected to public low-voltage systems with input current >16 A and ≤75 A per phase

IEC 61000-4-2:2008, Electromagnetic compatibility (EMC) - Part 4-2: Testing and measurement techniques - Electrostatic discharge immunity test

IEC 61000-4-3:2006, Electromagnetic compatibility (EMC) - Part 4-3: Testing and measurement techniques - Radiated, radio-frequency, electromagnetic field immunity test IEC 61000-4-3:2006/AMD1:2007 IEC 61000-4-3:2006/AMD2:2010

IEC 61000-4-4:2012, Electromagnetic compatibility (EMC) - Part 4-4: Testing and measurement techniques - Electrical fast transient/burst immunity test

IEC 61000-4-5:2014, Electromagnetic compatibility (EMC) - Part 4-5: Testing and measurement techniques - Surge immunity test IEC 61000-4-5:2014/AMD1:2017

IEC 61000-4-6:2013, Electromagnetic compatibility (EMC) - Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields

IEC 61000-4-8:2009, Electromagnetic compatibility (EMC) - Part 4-8: Testing and measurement techniques - Power frequency magnetic field immunity test

IEC 61000-4-11:2020, Electromagnetic compatibility (EMC) - Part 4-11: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests for equipment with input current up to 16 A per phase

CISPR 11:2015, Industrial, scientific and medical equipment - Radio-frequency disturbance characteristics - Limits and methods of measurement CISPR 11:2015/AMD1:2016

CISPR 11:2015/AMD2:2019